

Electronic Supplementary Information

## Physical Insights into Au Growth on Surface of LaAlO<sub>3</sub>/SrTiO<sub>3</sub> Heterointerface

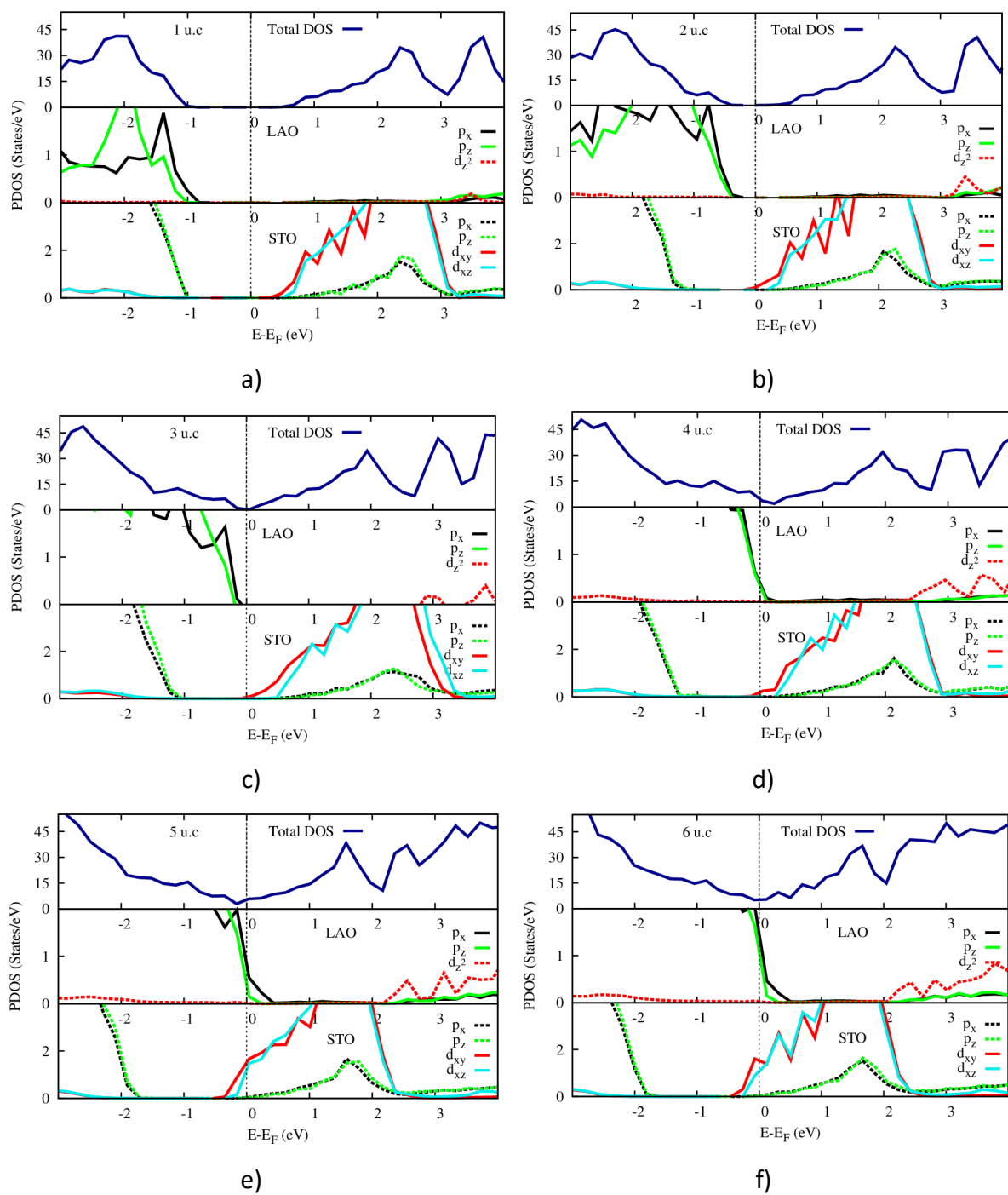
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**Figure S.** The orbital-projected density of states (PDOS) of the  $(\text{LAO})_m/(\text{STO})_6$  system,  $m = 1 - 6$  layers. Figures a) – f) correspond to the heterointerface with the LAO film thickness of 1 to 6 unit cells. The bandgap value is 1.41, 0.65, and 0.25 eV for the LAO film thickness of 1 to 3 unit cells, and that is 0 eV for the LAO film thickness  $\geq 4$  unit cells.